
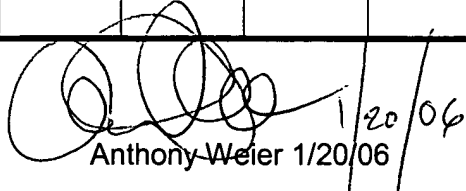



Issue Classification 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/684,074		EFSTATHIOU, JOHN D.	
	Examiner		Art Unit	
	Anthony Weier		1761	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
426		614			426	521	524		
INTERNATIONAL CLASSIFICATION									
A	2	3	L	1/32					
				/					
				/					
				/					
				/					

(Assistant Examiner) (Date)		 Anthony Weier 1/20/06 (Primary Examiner) (Date)		Total Claims Allowed: 23	
 (Legal Instruments Examiner) (Date)				O.G. Print Claim(s)	O.G. Print Fig.
				1	0

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
	1		31	23	61		91		121		151		181		
	2	4	32		62		92		122		152		182		
	3		33		63		93		123		153		183		
	4		34		64		94		124		154		184		
	5		35		65		95		125		155		185		
	6		36		66		96		126		156		186		
	7		37		67		97		127		157		187		
	8		38		68		98		128		158		188		
	9		39		69		99		129		159		189		
	10		40		70		100		130		160		190		
	11	5	41		71		101		131		161		191		
	12	6	42		72		102		132		162		192		
	13	7	43		73		103		133		163		193		
	14	8	44		74		104		134		164		194		
	15	9	45		75		105		135		165		195		
	16	10	46		76		106		136		166		196		
	17	11	47		77		107		137		167		197		
	18	12	48		78		108		138		168		198		
	19	13	49		79		109		139		169		199		
	20		50		80		110		140		170		200		
	21		51		81		111		141		171		201		
	22	14	52		82		112		142		172		202		
	23	15	53		83		113		143		173		203		
	24	16	54		84		114		144		174		204		
	25	17	55		85		115		145		175		205		
	26	18	56		86		116		146		176		206		
	27	19	57		87		117		147		177		207		
1	28	20	58		88		118		148		178		208		
2	29	21	59		89		119		149		179		209		
3	30	22	60		90		120		150		180		210		